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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/629,939	SHYAM ET AL.	
Examiner	Art Unit	
Leon J. Harper	2166	_

	SEARCHED		
Class	Subclass	Date	Examiner
707	104.1,100, 10,1,5,3	2/1/2006	LJH

INTERFERENCE SEARCHED			
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